

Notice of References Cited	Application/Control No. 09/903,764	Applicant(s)/Patent Under Reexamination OKU ET AL.	
	Examiner Khiem D Nguyen	Art Unit 2823	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,989,998	11-1999	Sugahara et al.	438/623
*	B	US-6,642,157	11-2003	Shioya et al.	438/789
	C	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 1 174 915 A2	01-2002	European	Junichi et al.	H01L 21/316
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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